

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KIMIZUKA ET AL.	
		Examiner RACHEL KAHN	Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,576,679	06-2003	Kimizuka et al.	516/102
*	C	US-6,210,537	04-2001	Murphy et al.	204/157.15
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	K	US-			
	L	US-			
	M	US-			

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	N	JP 94041532 B2	06-1994	Japan	ASAKUMA S et al.	
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NON-PATENT DOCUMENTS

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	U	Cheung et al, Molecular Organization and Electrical Properties of Mixed Langmuir-Blodgett Multilayer Thin Films of Polypyrrole, 1990, Conjugated Polymeric Materials, Bredas and Chance (eds), p91-99.
	V	Kimizuka et al, AFM Observation of Organogel Nanostructures on Graphite in the Gel-Assisted Transfer Technique, Chemistry Letters, 1998, p 967-68.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.